

**Search Notes**

Application/Control No.

10/697,241

Examiner

Quang N. Nguyen

Applicant(s)/Patent under  
Reexamination

FLUCK ET AL.

Art Unit

2141

**SEARCHED**

Class	Subclass	Date	Examiner
709	203	8/6/2007	QN
709	217	8/6/2007	QN
709	219	8/6/2007	QN
700	83	8/6/2007	QN
717	716	8/6/2007	QN
709	230	4/3/2008	QN
709	231	4/3/2008	QN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
<b>709</b>	<b>203</b>	4/3/2008	<b>QN</b>
709	217	4/3/2008	QN
709	219	4/3/2008	QN
709/230, 231		4/3/2008	QN

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Inventor Name Search	8/6/2007	QN
East Search (see notes)	8/6/2007	QN
East Search (see notes)	4/3/2008	QN
IEEE Search (see notes)	4/3/2008	QN
Google Search (see notes)	4/3/2008	QN